

Description

The STD20NF06L uses advanced trench technology

to provide excellent $R_{\text{DS}(\text{ON})},$ low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 60V I_D =20 A

 $R_{DS(ON)} < 32m\Omega @ V_{GS}=10V$

Application

Battery protection

Load switch

Uninterruptible power supply

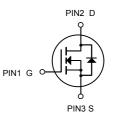
Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
STD20NF06L	TO-252-2L	HXY MOSFET	2500

Absolute Maximum Ratings (Tc=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units	
Vds	Drain-Source Voltage	60	V	
Vgs	Gate-Source Voltage	±20	V	
I⊳@Tc=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	20	А	
I₀@Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	10	А	
Ідм	Pulsed Drain Current ²	80	А	
EAS	Single Pulse Avalanche Energy ³	38	mJ	
P₀@T _C =25°C	Total Power Dissipation ⁴	34.7	W	
Тѕтс	TstgStorage Temperature RangeTJOperating Junction Temperature Range		°C	
TJ			°C	





N-Channel MOSFET



STD20NF06L

N-Channel Enhancement Mode MOSFET

Parameter		Symbol Test Conditions		Min.	Тур.	Max.	Unit	
Static Characteristics		1	1		1	1	1	
Drain-Source Breakdown Voltage Gate-Body Leakage Current		V (BR) DSS V _{GS} = 0V, I _D = 250µA		60	-	-	V	
		IGSS $V_{DS} = 0V, V_{GS} = \pm 20V$		-	-	±100	nA	
Zero Gate Voltage Drain	TJ=25℃	- I _{DSS}		-	-	1	μA	
Current	TJ=100℃		$V_{DS} = 60V, V_{GS} = 0V$	-	-	100		
Gate-Threshold Voltage		V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.2	1.7	2.5	V	
		_	V _{GS} = 10V, I _D = 10A	-	25	32		
Drain-Source on-Resistance	<u>)</u>	R _{DS(on)}	V _{GS} = 4.5V, I _D = 5A	-	31.5	40	mΩ	
Forward Transconductance	1	g fs	V _{DS} = 5V, I _D = 10A	-	15.5	-	S	
Dynamic Characteristic	S ⁵			1	L			
Input Capacitance		Ciss		-	1355	-		
Output Capacitance Reverse Transfer Capacitance Gate Resistance		Coss	V _{DS} = 30V, V _{GS} =0V, f =1MHz	-	60	-	pF	
		Crss		-	49	-		
		Rg	f =1MHz	-	1.2	-	Ω	
Switching Characteristi	CS ⁵					•		
Total Gate Charge		Qg		-	22	-		
Gate-Source Charge		Q _{gs}	V _{GS} = 10V, V _{DD} = 30V, I _D = 10A	-	4.2	-	nC	
Gate-Drain Charge		Q _{gd}		-	6.9	-		
Turn-on Delay Time		t _{d(on)}		-	6.4	-		
Rise Time		tr	$V_{GS} = 10V, V_{DD} = 30V, R_G = 3\Omega, I_D = 10A$	-	15.3	-	. ns	
Turn-off Delay Time		t _{d(off)}		-	25	-		
Fall Time		tr		-	7.6	-		
Body Diode Reverse Recovery Time		trr		-	26	-	ns	
Body Diode Reverse Recovery Charge		Qrr	I _F =10A, dI _F /dt=100A/µs	-	45	-	nC	
Drain-Source Body Dio	de Characte	ristics		I		1		
Diode Forward Voltage ⁴		Vsd	Is = 10A, V _{GS} = 0V	-	-	1.2	V	
Continuous Source Current	T _C =25℃	Is	_	_	-	20	А	

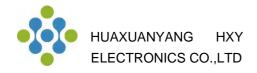
Notes:

1. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}\text{=}150^\circ\text{C}$

2. The EAS data shows Max. rating . The test condition is $V_{\text{DD}}\text{=}25V,\,V_{\text{GS}}\text{=}10V,\,L\text{=}0.4\text{mH},\,I_{\text{AS}}\text{=}14\text{A}$

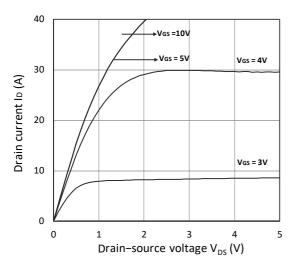
- 3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- 4. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.

5. This value is guaranteed by design hence it is not included in the production test.



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Typical Characteristics





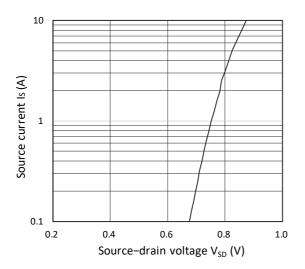


Figure 3. Forward Characteristics of Reverse

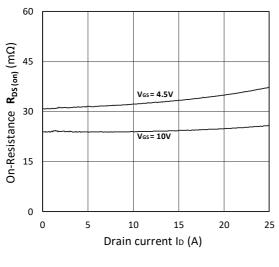


Figure 5. $R_{\text{DS}(\text{ON})}$ vs. I_{D}

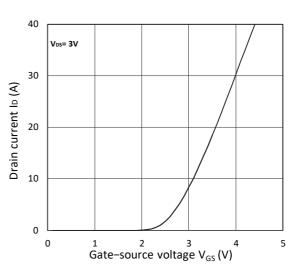
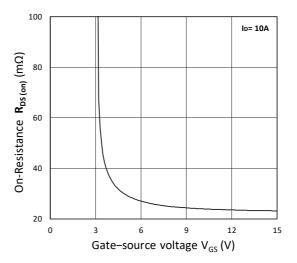


Figure 2. Transfer Characteristics





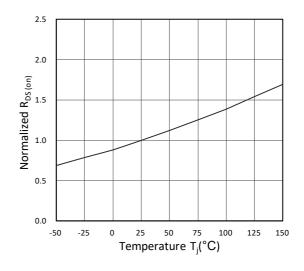
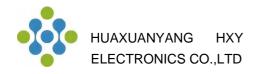


Figure 6. Normalized R_{DS(on)} vs. Temperature



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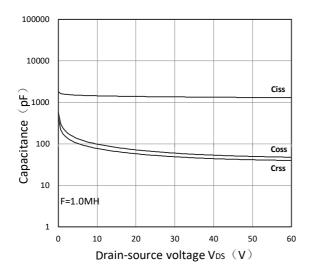
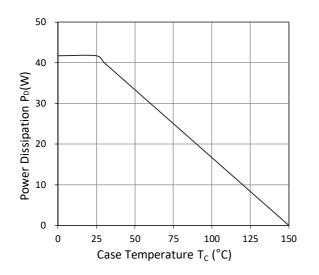


Figure 7. Capacitance Characteristics





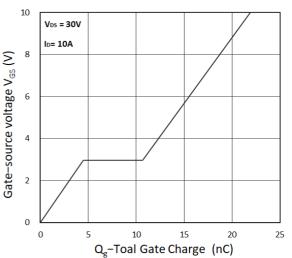
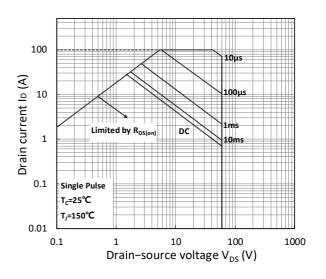
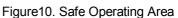
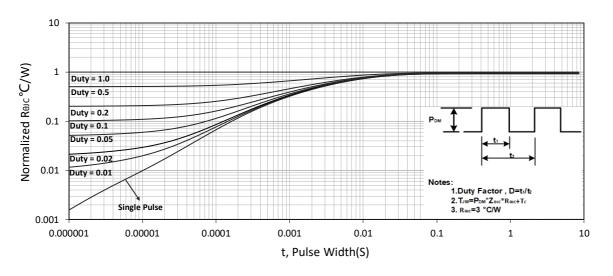
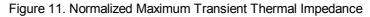


Figure 8. Gate Charge Characteristics



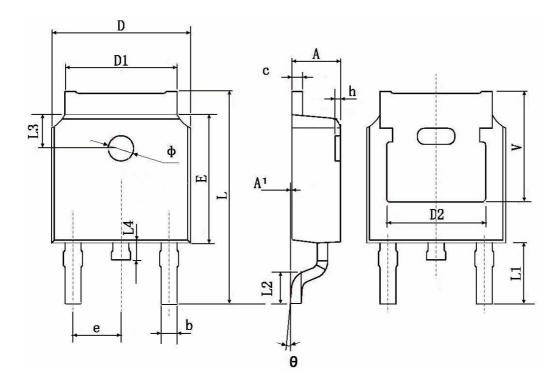








TO-252-2L Package Information



Ourseland	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	0.483	0.483 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900 TYP.		0.114 TYP.		
L2	1.400	1.700	0.055	0.067	
L3	1.600 TYP.		0.063 TYP.		
L4	0.600	1.000	0.024	0.039	
Φ	1.100	1.300	0.043	0.051	
θ	0°	8°	0 °	8°	
h	0.000	0.300	0.000	0.012	
V	5.350	TYP.	0.211 TYP.		



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